

NiH₂ LEO Cycle Life Study

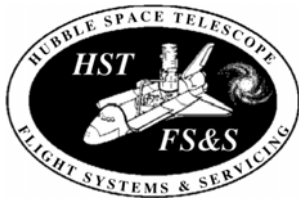
Roger P. Hollandsworth

Jon D. Armantrout

**Lockheed Martin Space Systems Operations
Sunnyvale, CA**

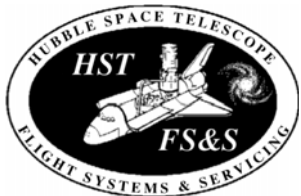
Gopalakrishna M. Rao

**NASA/Goddard Space Flight Center
Greenbelt, MD**



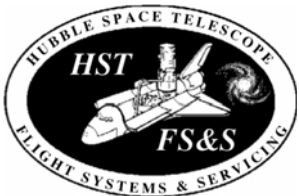
Mantech Cell Cycle Test History

- **Mantech Cells on Duty Cycle Test at 41 °F at Various Load Levels Since 1996**
 - Generic LEO Load Profile with Peak Load Test for Minimum Voltage Test
 - Concern With Spacecraft is Low Bus Voltage Trip into Safe-Mode
 - Reconditioning Scheduled Annually During Cycling
 - Also Perform Reconditioning to Maintain Voltages Above Minimum Requirement
 - 19 - 22 Cells in Series Configuration
- **Lot 1 Slurry Process Cells Added 3/96 - Completed 35.2K Cycles**
- **Lot 2, 3 Slurry Process Cells Added 9/97 - Completed 26.7K Cycles**
- **HST Dry Sinter Cells (3) added 9/97**
 - Previously Cycled 6 Years at MSFC (~33K Cycles) - Unknown Storage History
 - Removed From Test 10/00 (16K + ~33K Cycles) - Cold Storage @ EPT
- **Lot 5 Slurry Process Cells Added 10/98 - Completed 21.0K Cycles**
- **Lot 6 Slurry Process Cells Added 10/00 - Completed 10.5K Cycles**

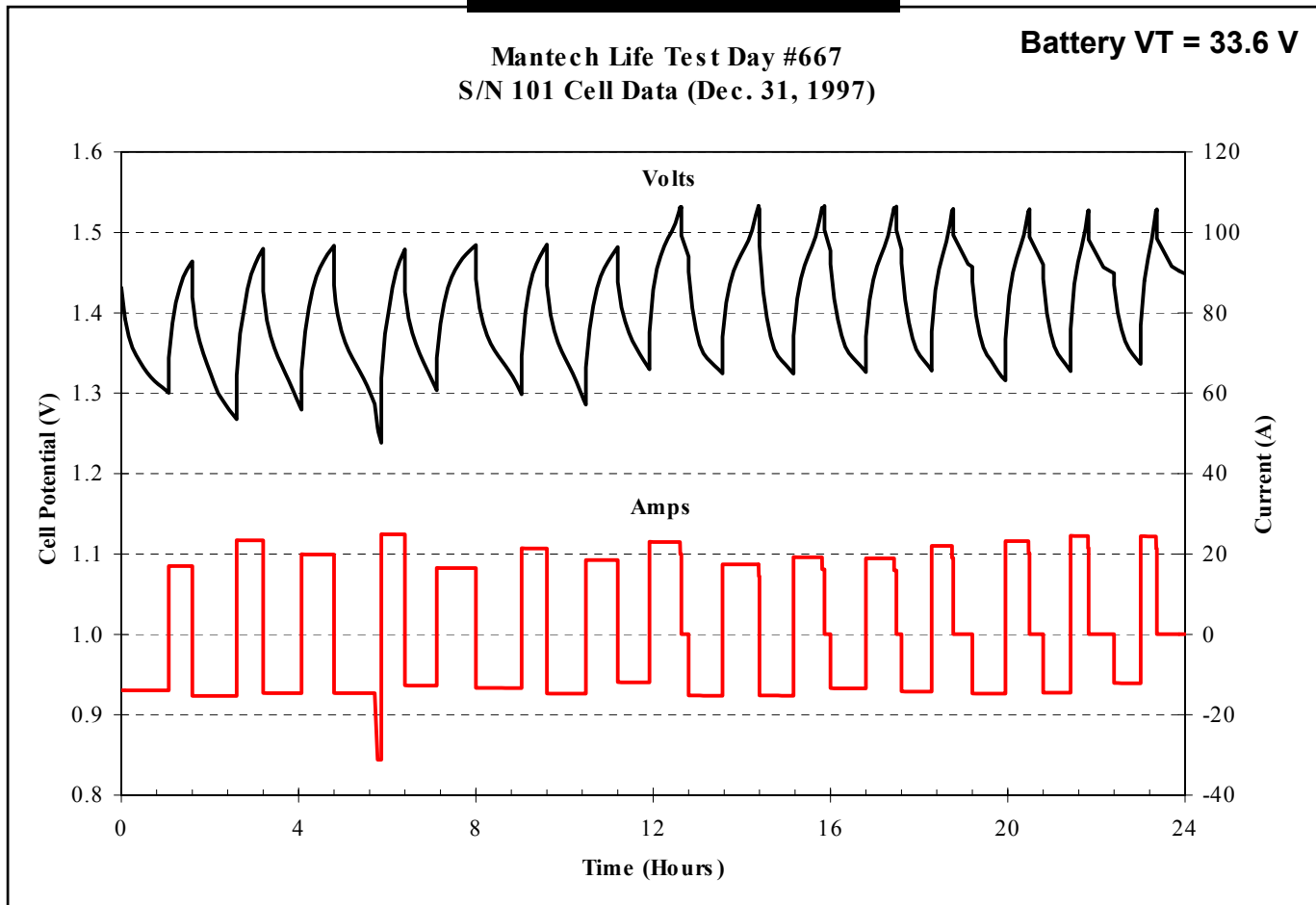


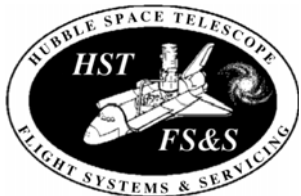
Eagle Picher Cell Life Test Load Profiles

Test	Ave. Dischg.	Ave. Dischg.	Ave. Batt. Load	Max. DOD	Peak Load	Battery	Profile	Comments
Profile	Amps	Minutes	Ahout/rev	AH	Amps	Max V	Dates	
ML1	12.8	52.3	11.2	28.8	15.2	33.1	3/14/96 -	Lot 1 Cells (3/96)
ML2	12.8	52.3	11.2	33.0	25.0	33.1	- 4/26/97	
HL1	16.2	49.3	13.3	32.4	32.4	33.1/33.6	4/26/97 - 8/18/97	
HL7	14.8	49.3	12.2	25.1	31.2	33.6	8/18/97 - 9/13/97	
HL8	14.2	49.3	11.7	22.0	31.2	33.6	9/13/97 - 1/28/98	Lot 2, 3, HST Cells Added (9/97)
UHL	11.7	47.3	9.2	40.8	27.3	33.2	1/28/98 - 5/23/98	
HL8	14.2	49.3	11.7	22.0	31.2	33.2	5/23/98 - 10/9/98	
HL10M	15.0	49.3	12.4	30.0	32.3	33.2/33.6	10/9/98 - 8/9/99	Lot 5 Cells Added (10/98)
HL12M	13.9	49.3	11.4	25.7	29.4	32.8/33.0	8/9/99 - 6/22/01	HST Cells Removed Lot 6 Added (10/00)
HL14R	10.8	47.4	8.6	14.1	30.0	32.8	6/22/01 - 3/21/02	
HL15R	10.8	47.4	8.6	17.1	30.0	32.8/33.0	3/21/02 -	

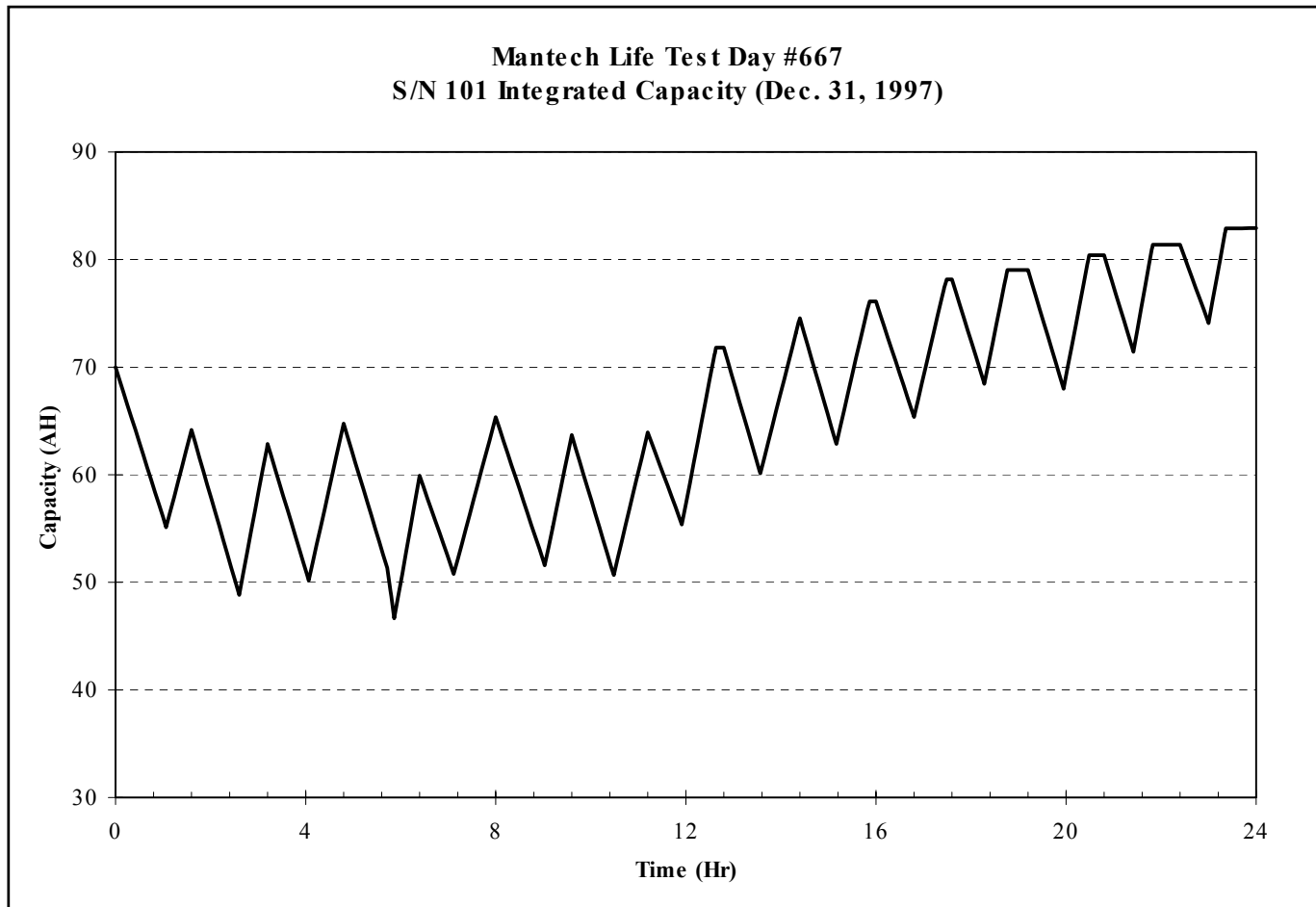


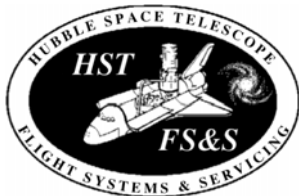
Cell Life Study HL8 Test Profile



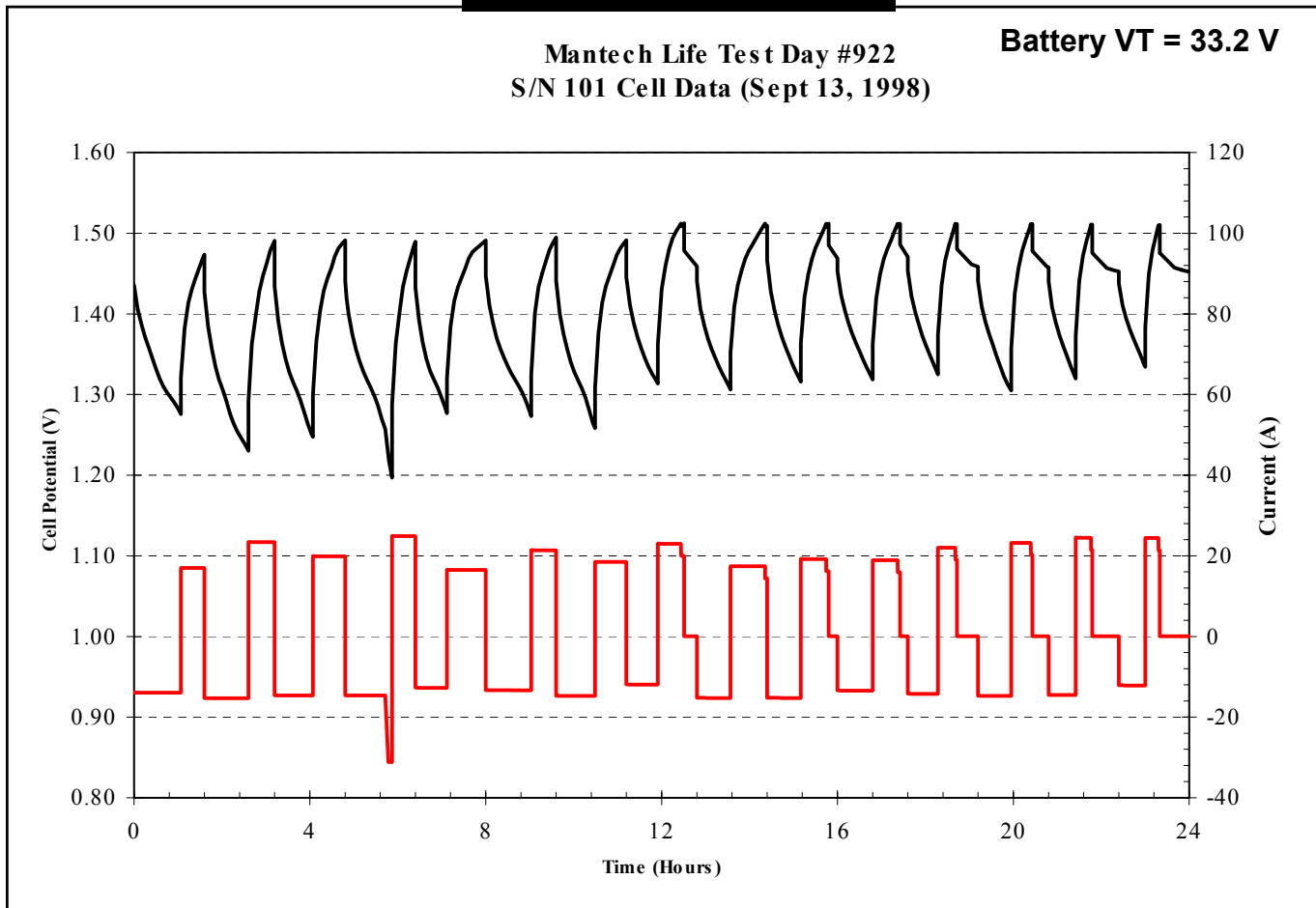


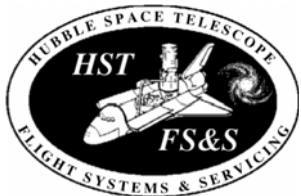
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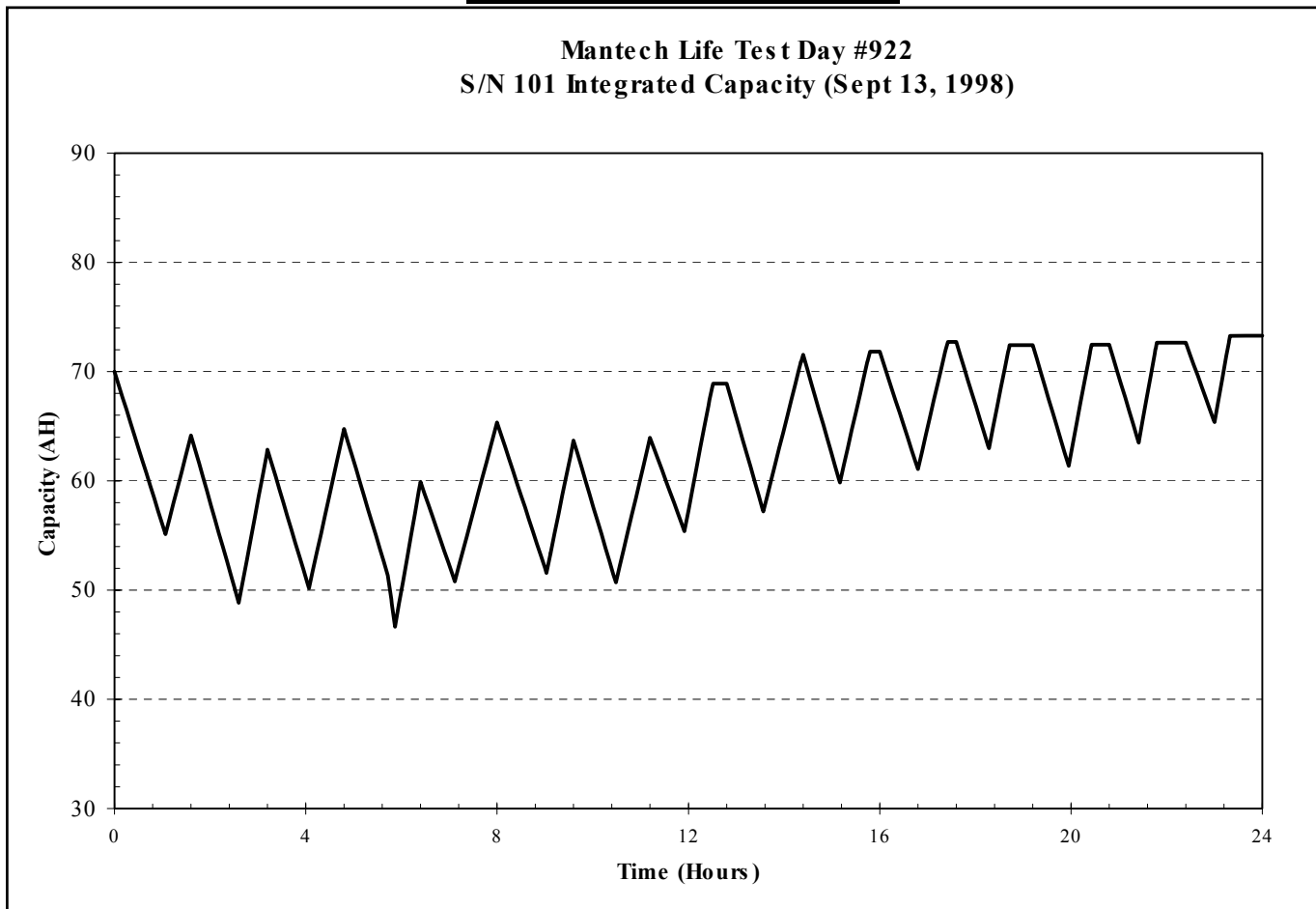


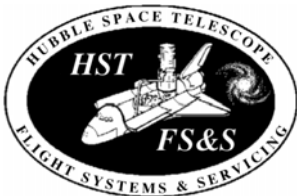
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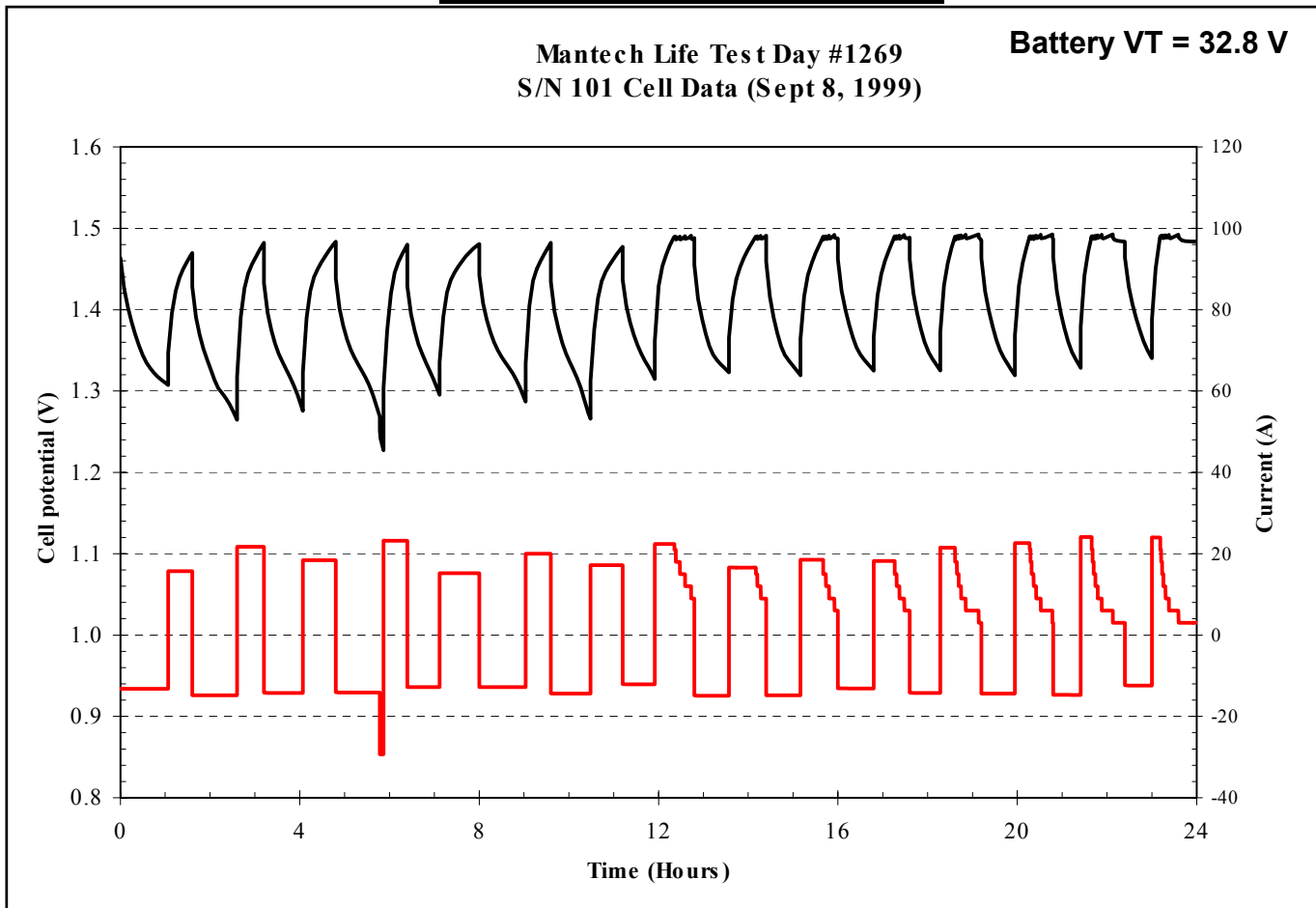


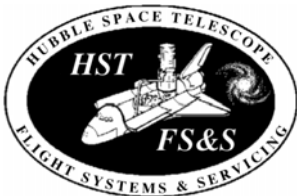
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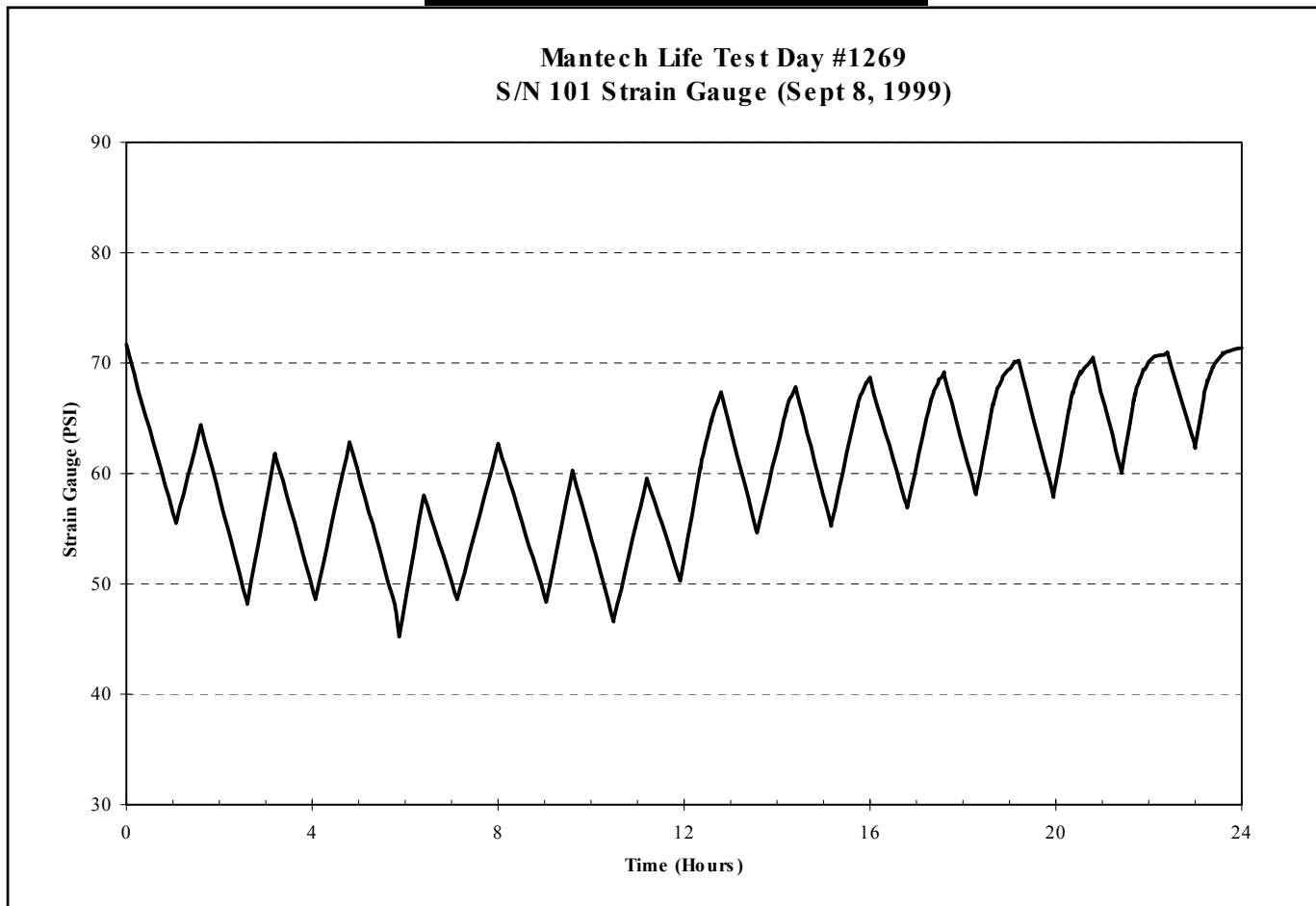


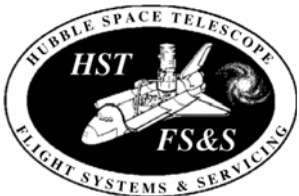
Cell Life Study HL10M Test Profile



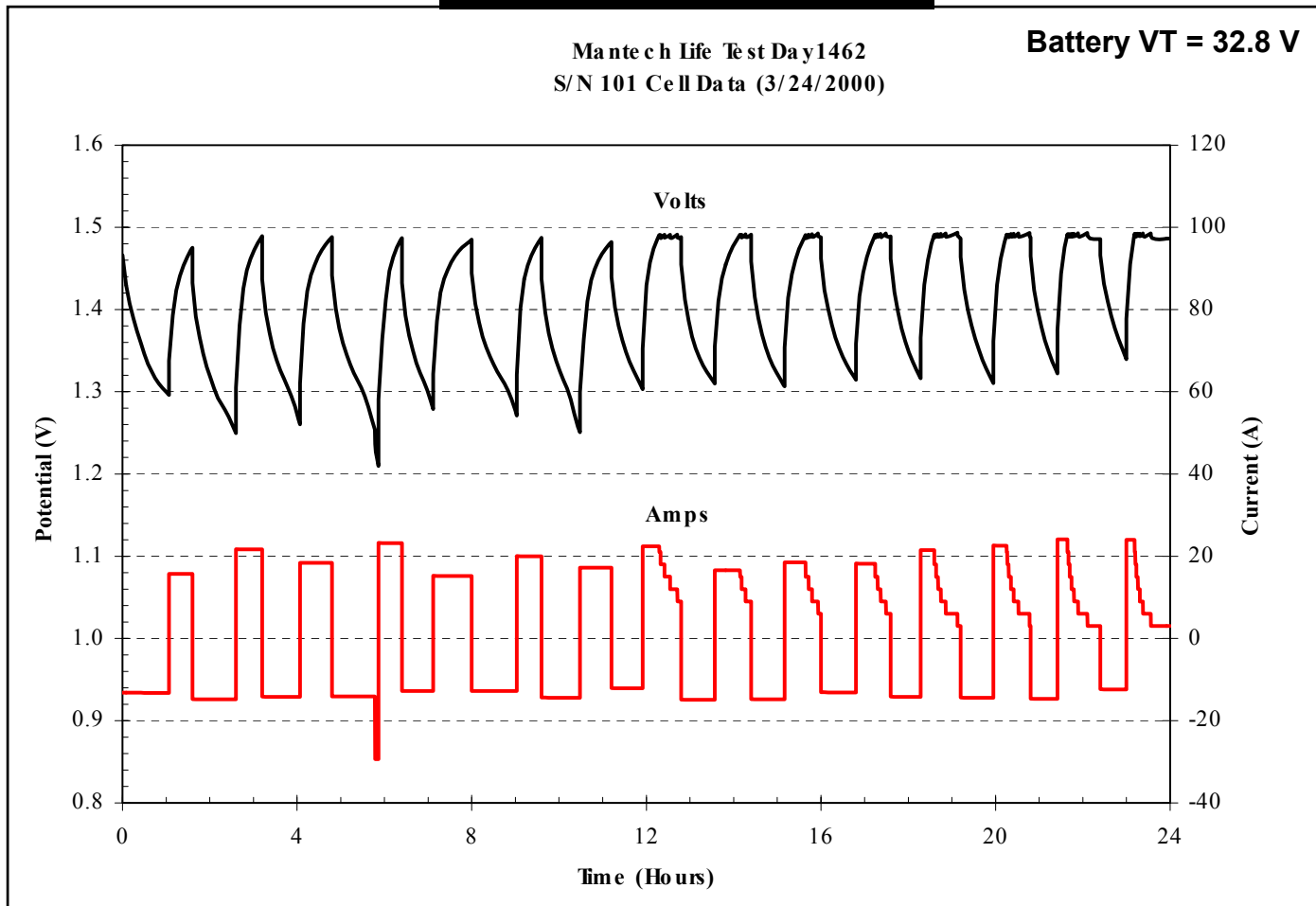


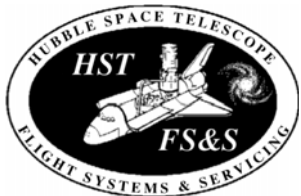
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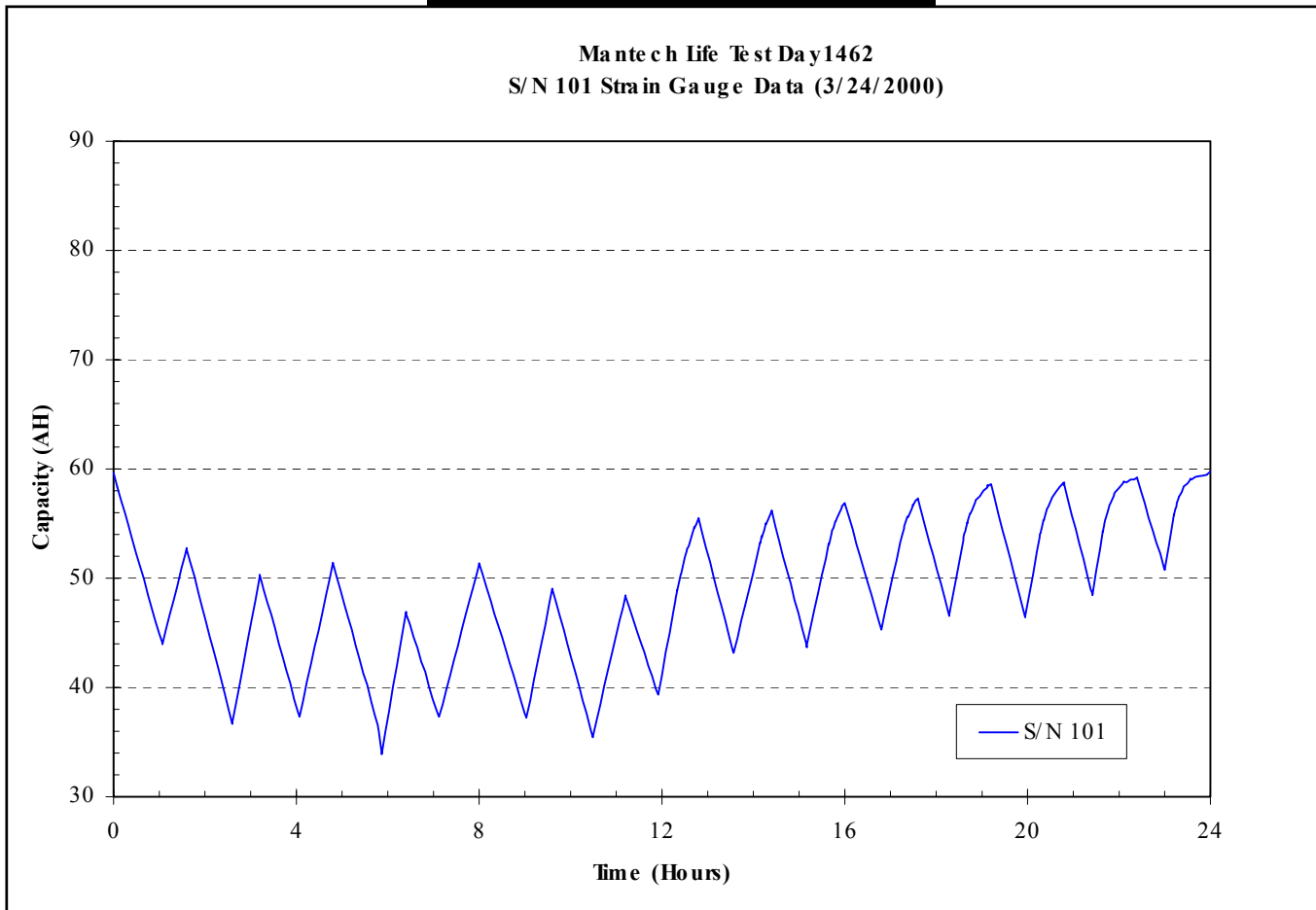


Cell Life Study HL12M Test Profile



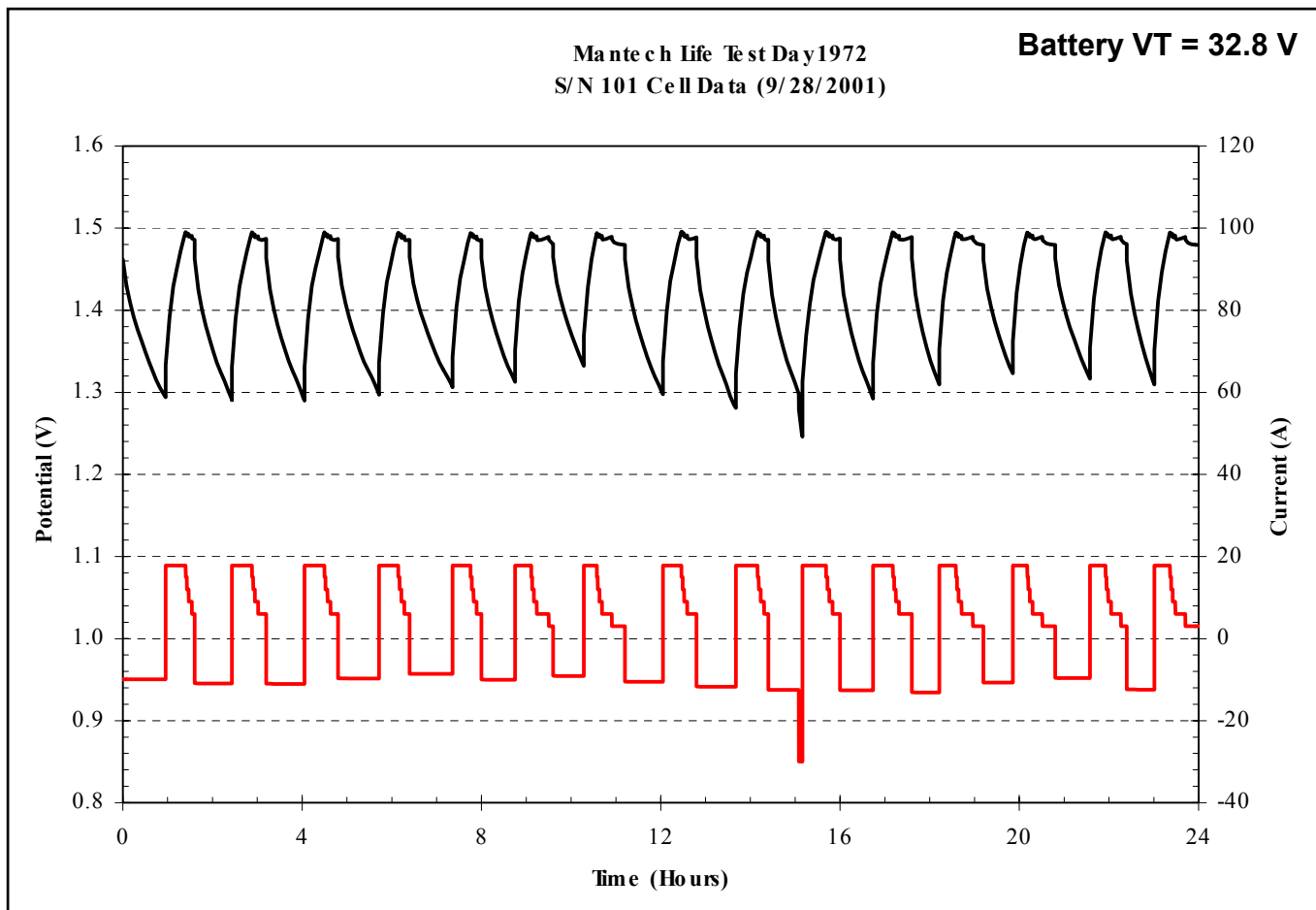


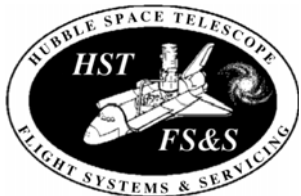
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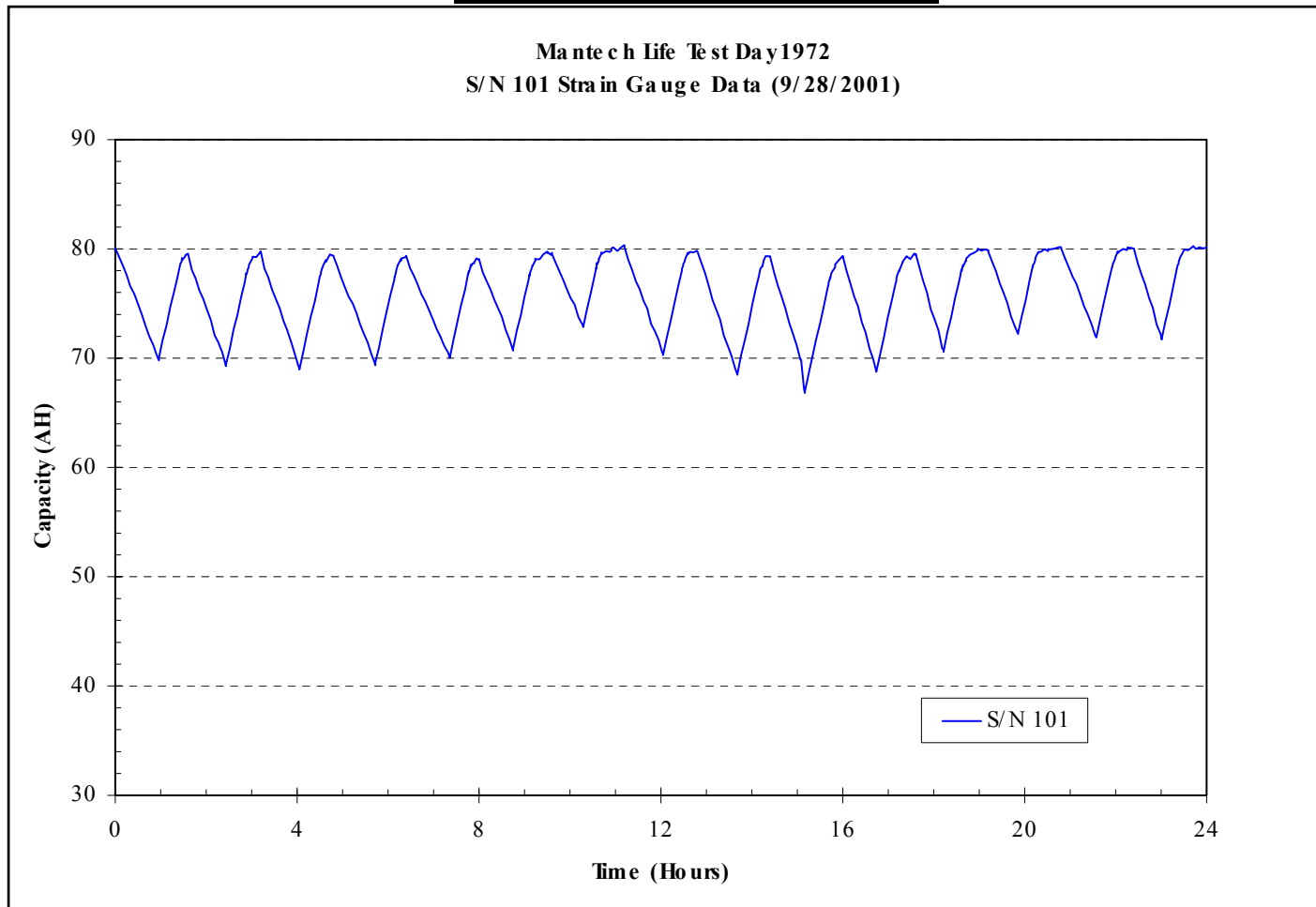


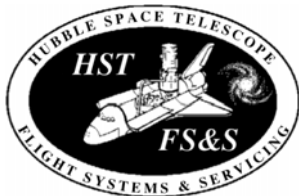
Cell Life Study HL14R Test Profile



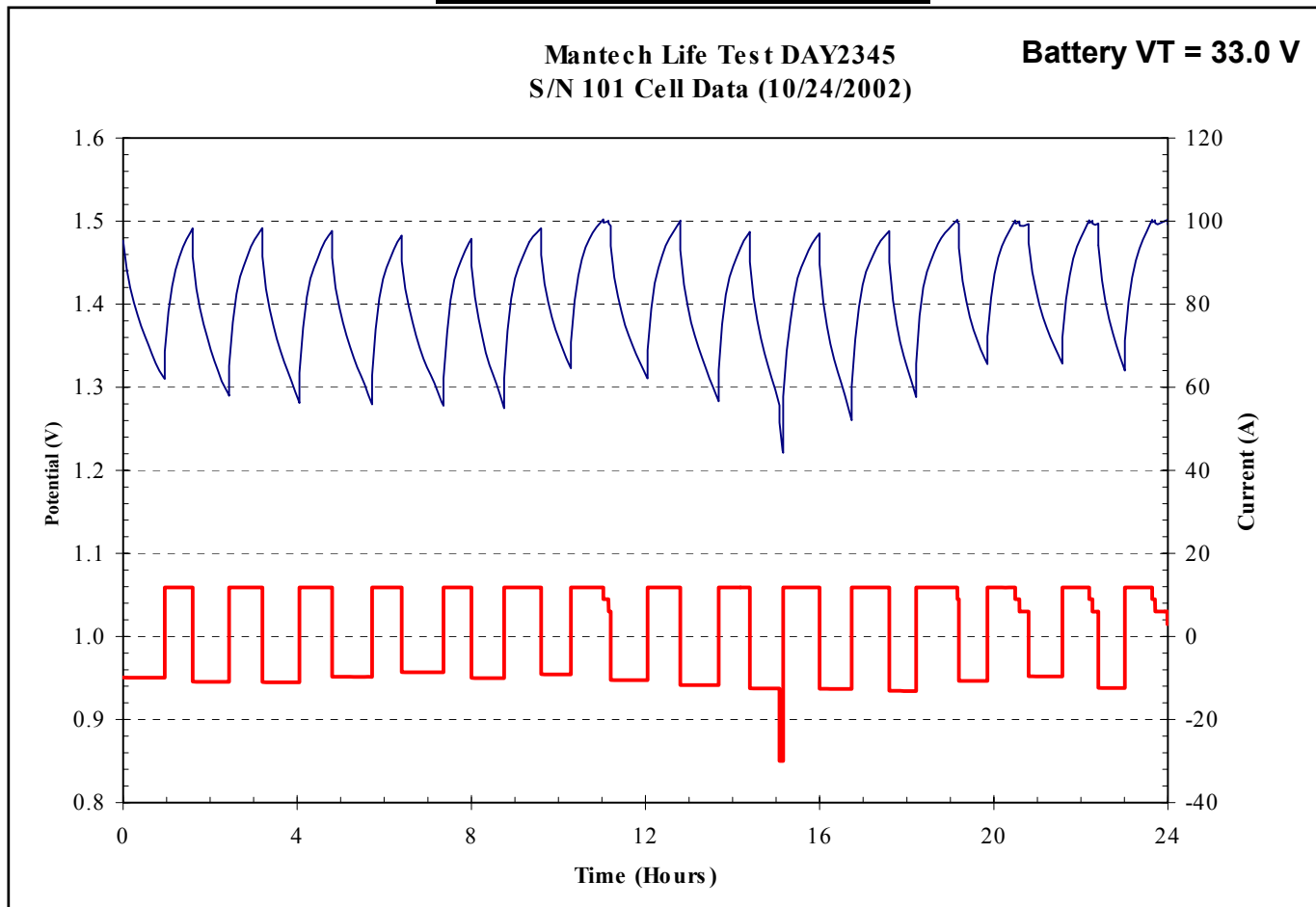


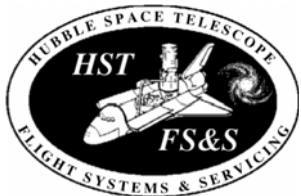
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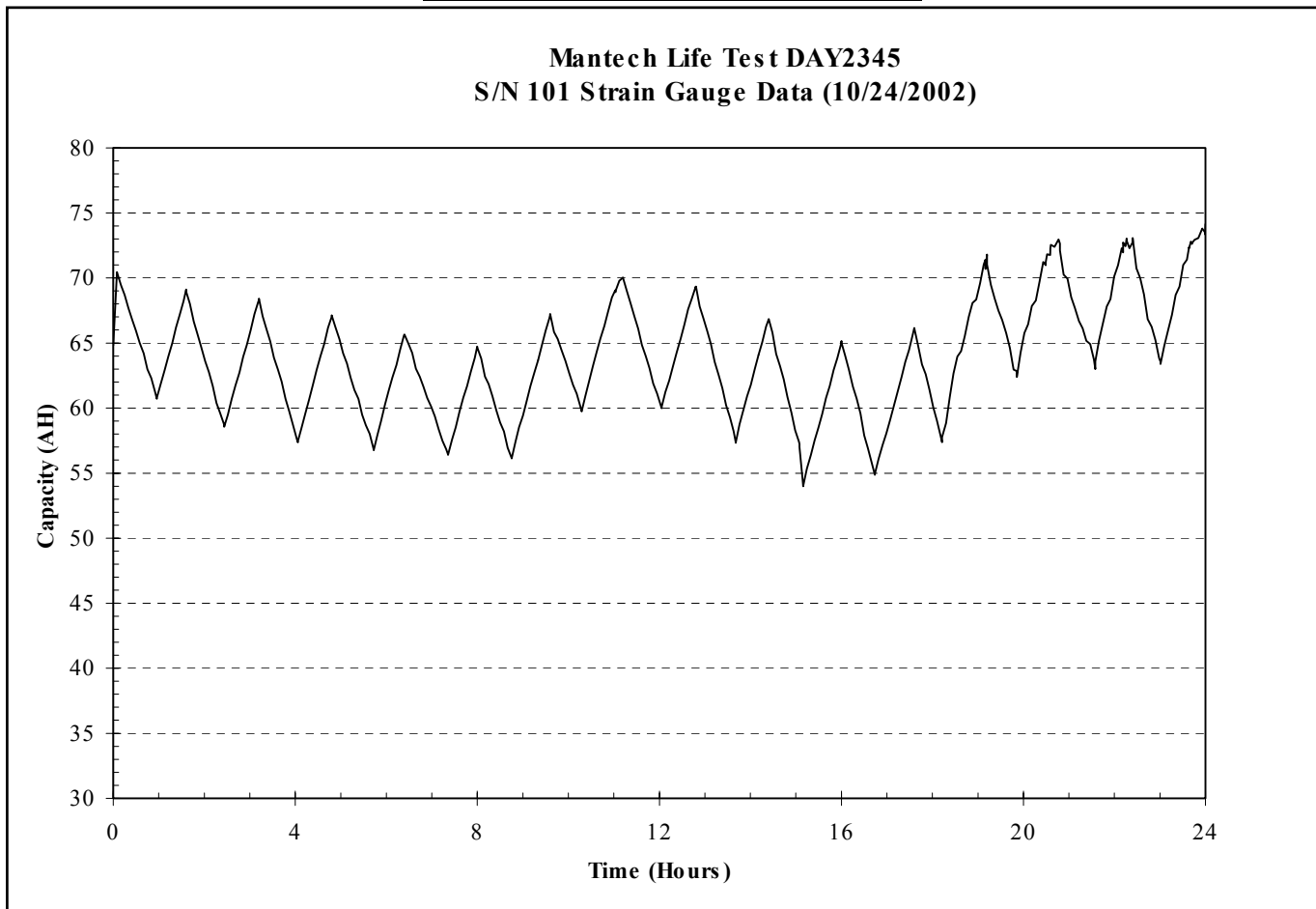


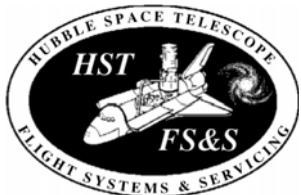
Cell Life Study HL15R Test Profile



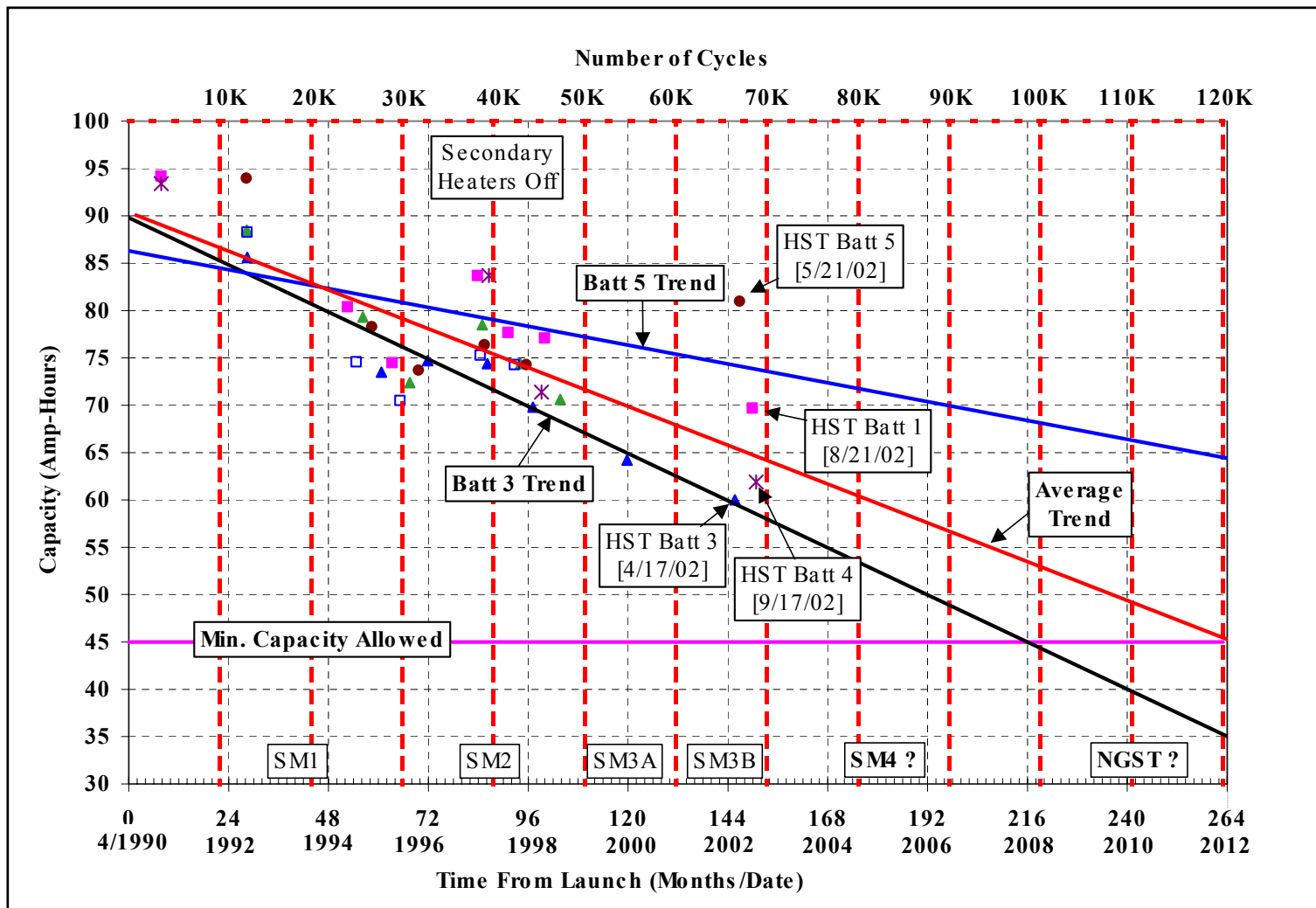


Cell Life Study HL15R Test Profile

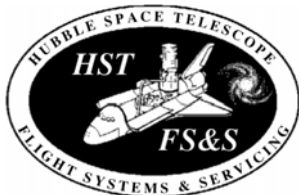




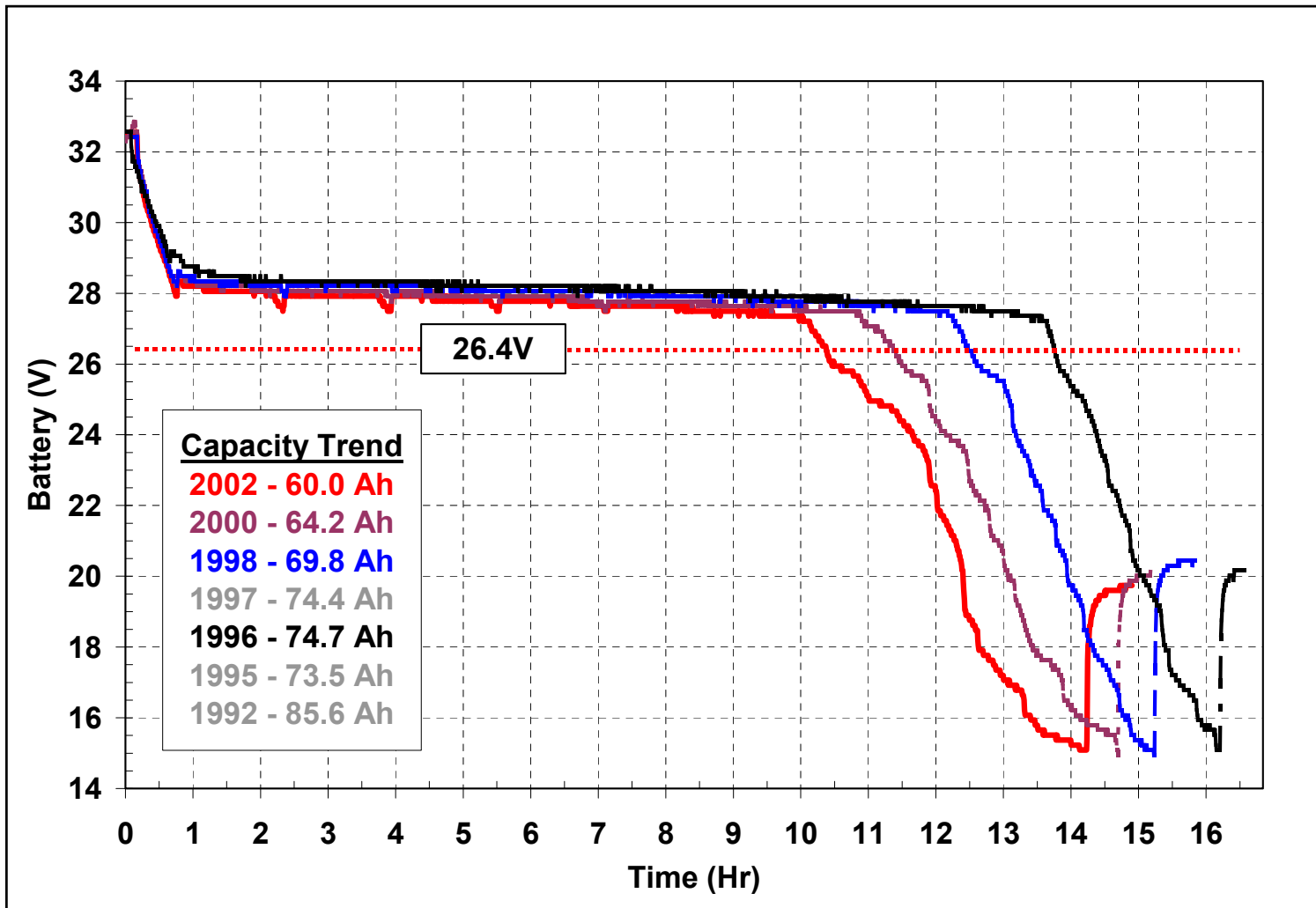
HST Orbital Capacity Trend



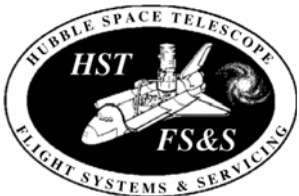
IECEC-2002



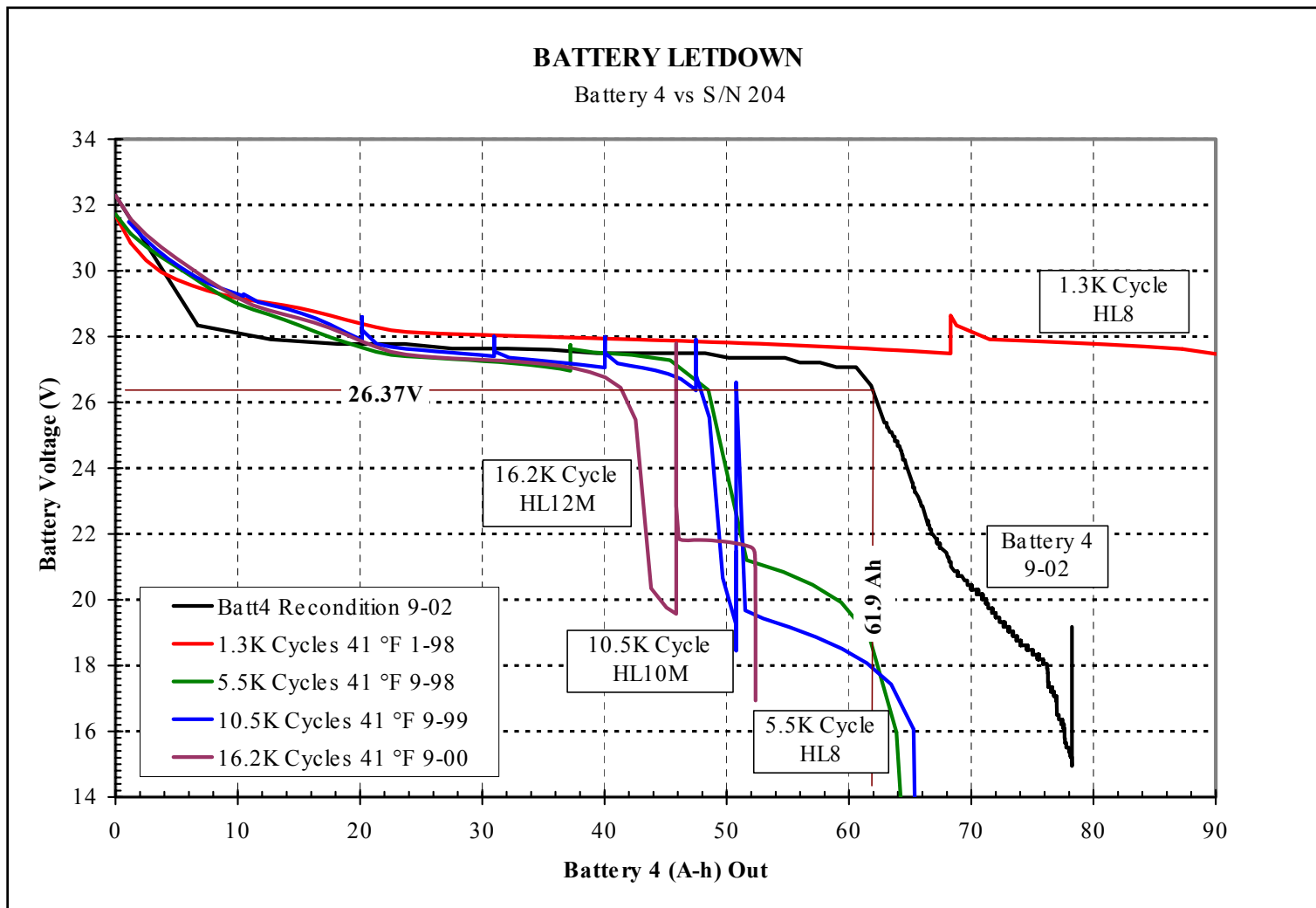
HST Orbital Recondition Capacity Trend Battery 3

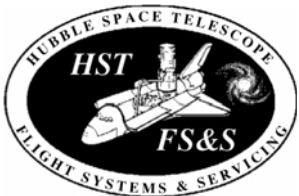


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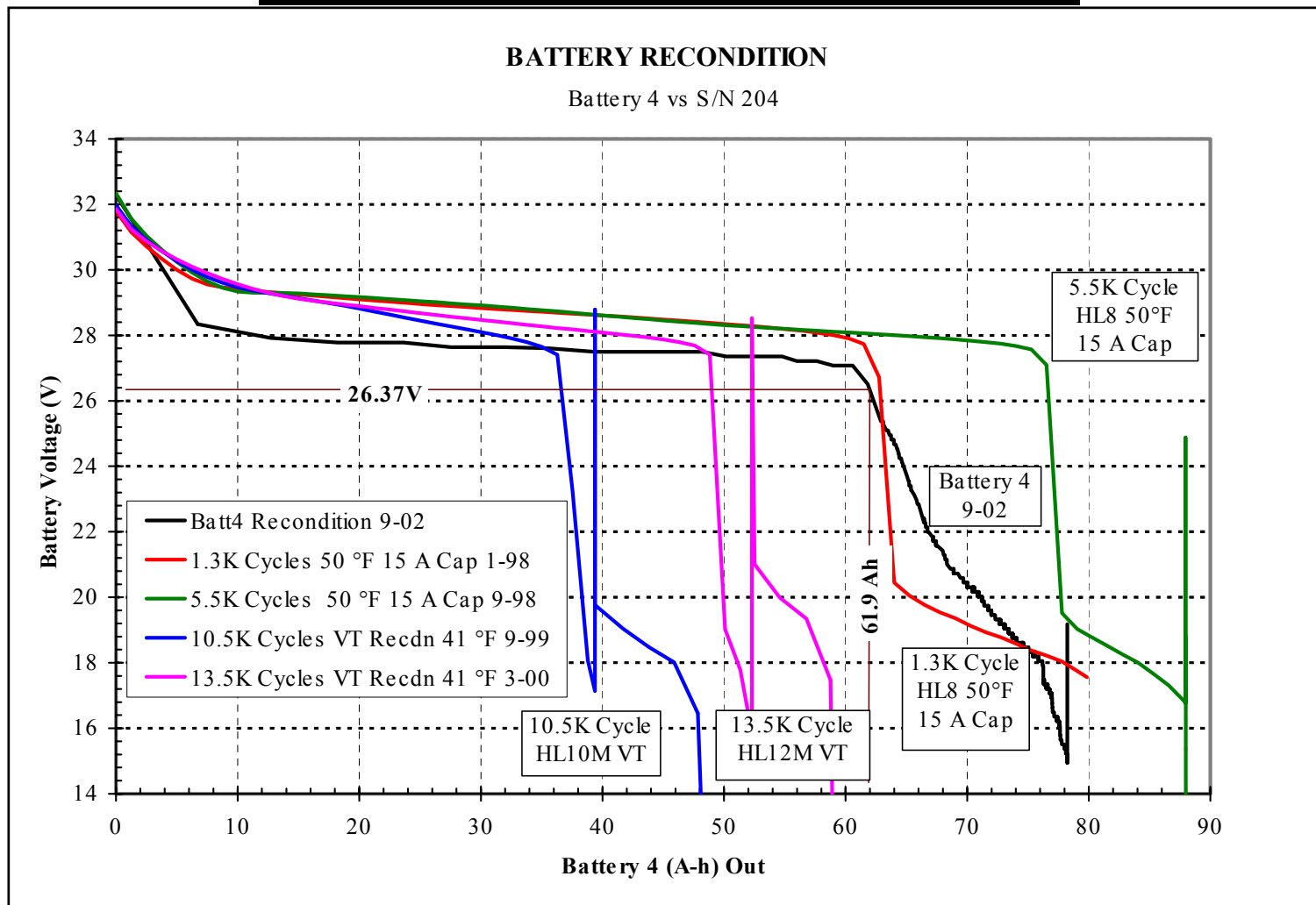


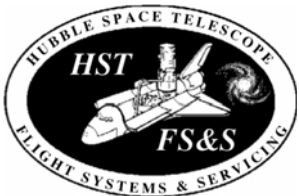
HST Recondition Capacity Comparison Battery 4 Orbital vs S/N 204 Ground



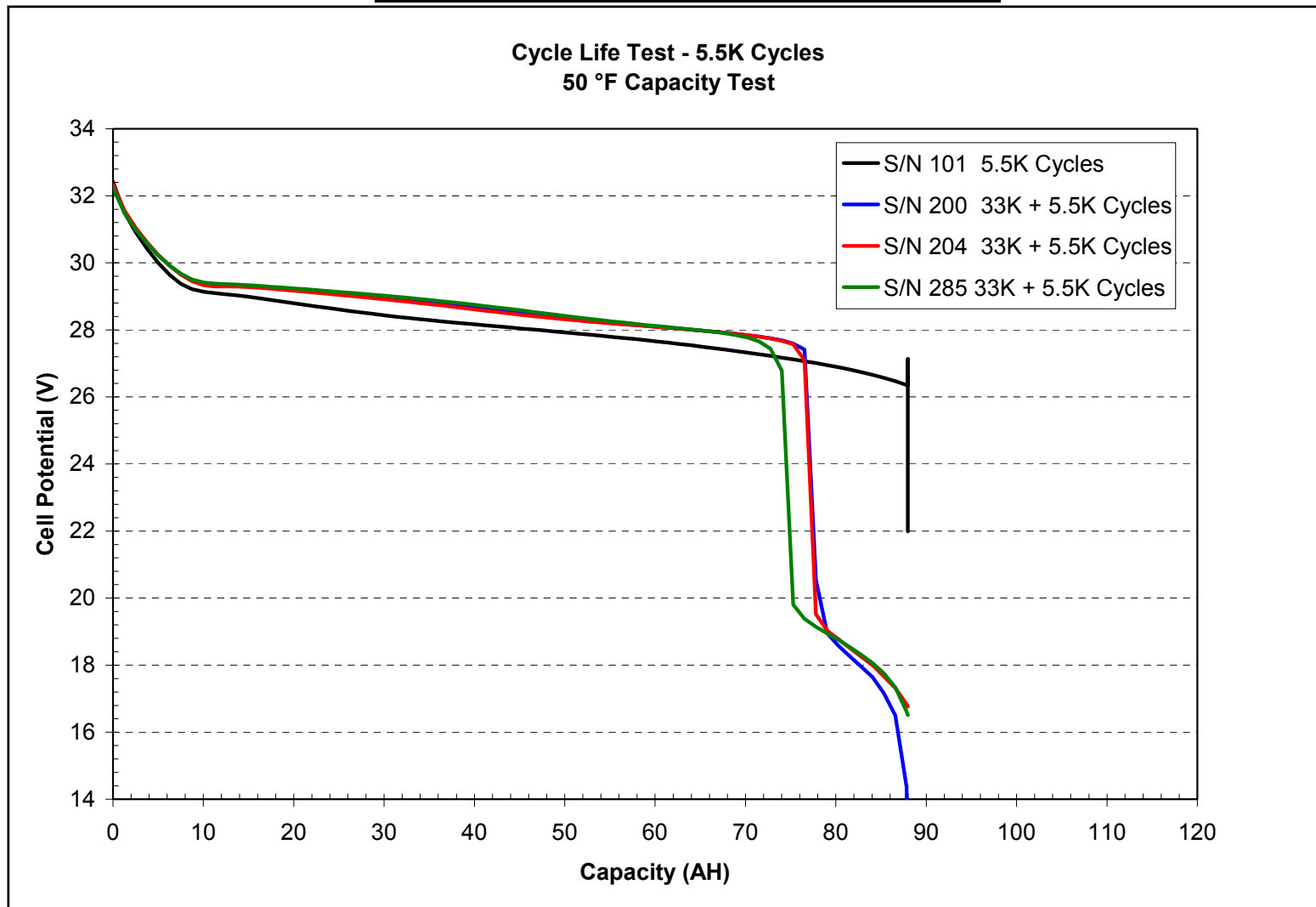


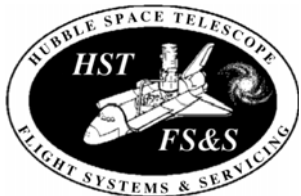
HST Recondition Capacity Comparison Battery 4 Orbital vs S/N 204 Ground



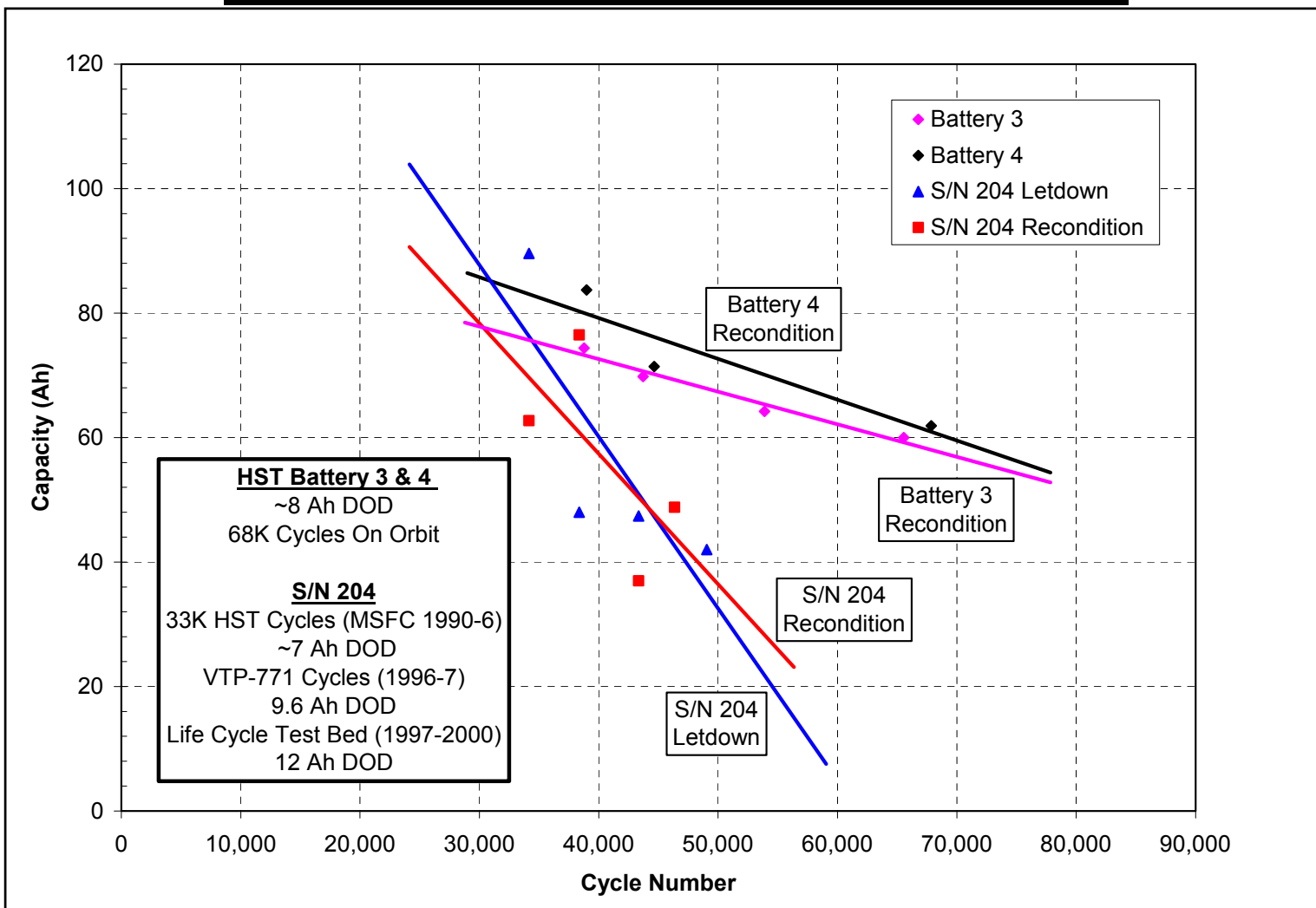


50 °F Capacity Test Comparison Cycle Life Test

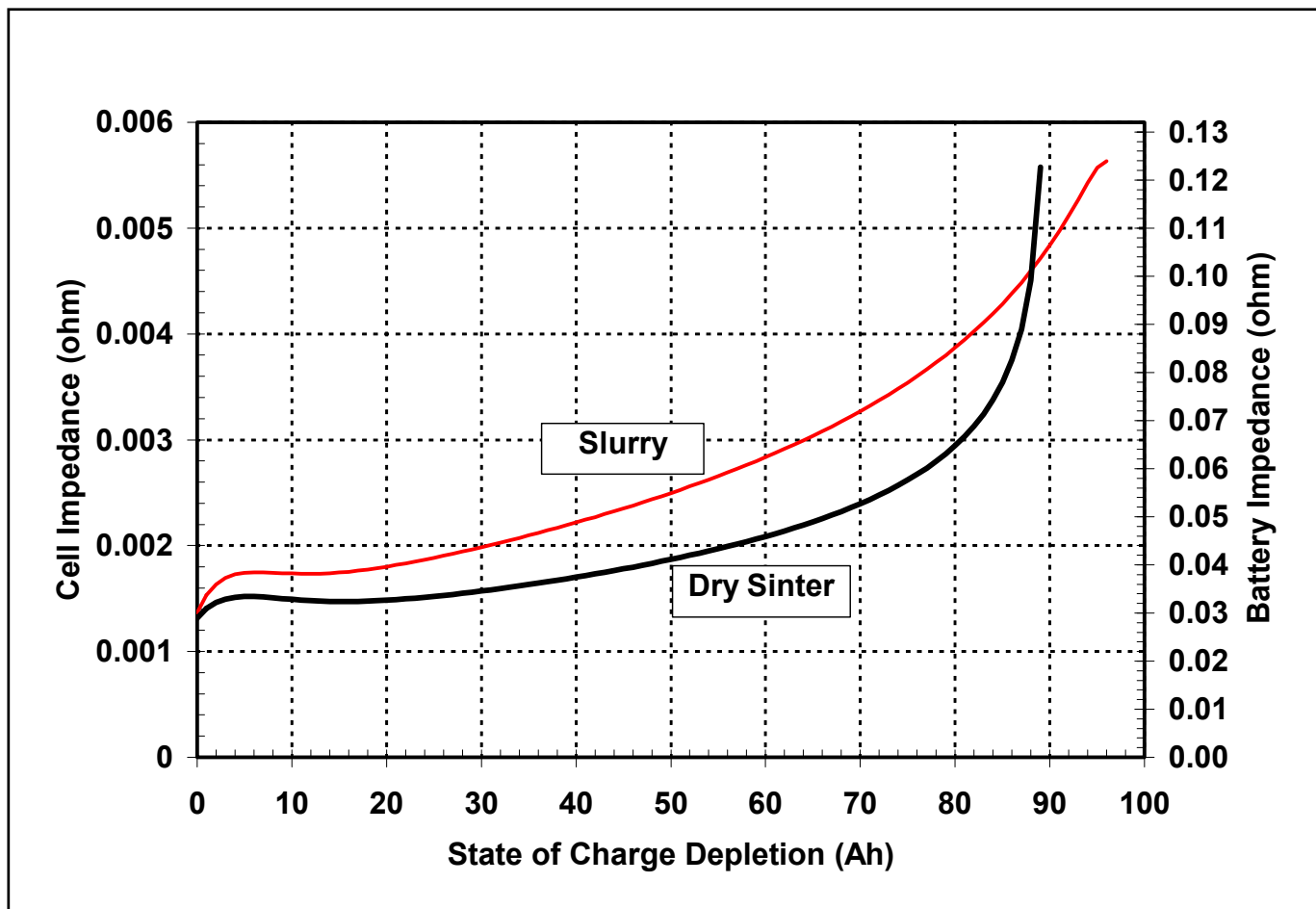


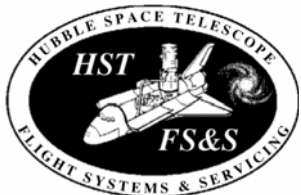


HST Recondition Capacity Comparison Battery 3 & 4 Orbital vs S/N 204 Ground

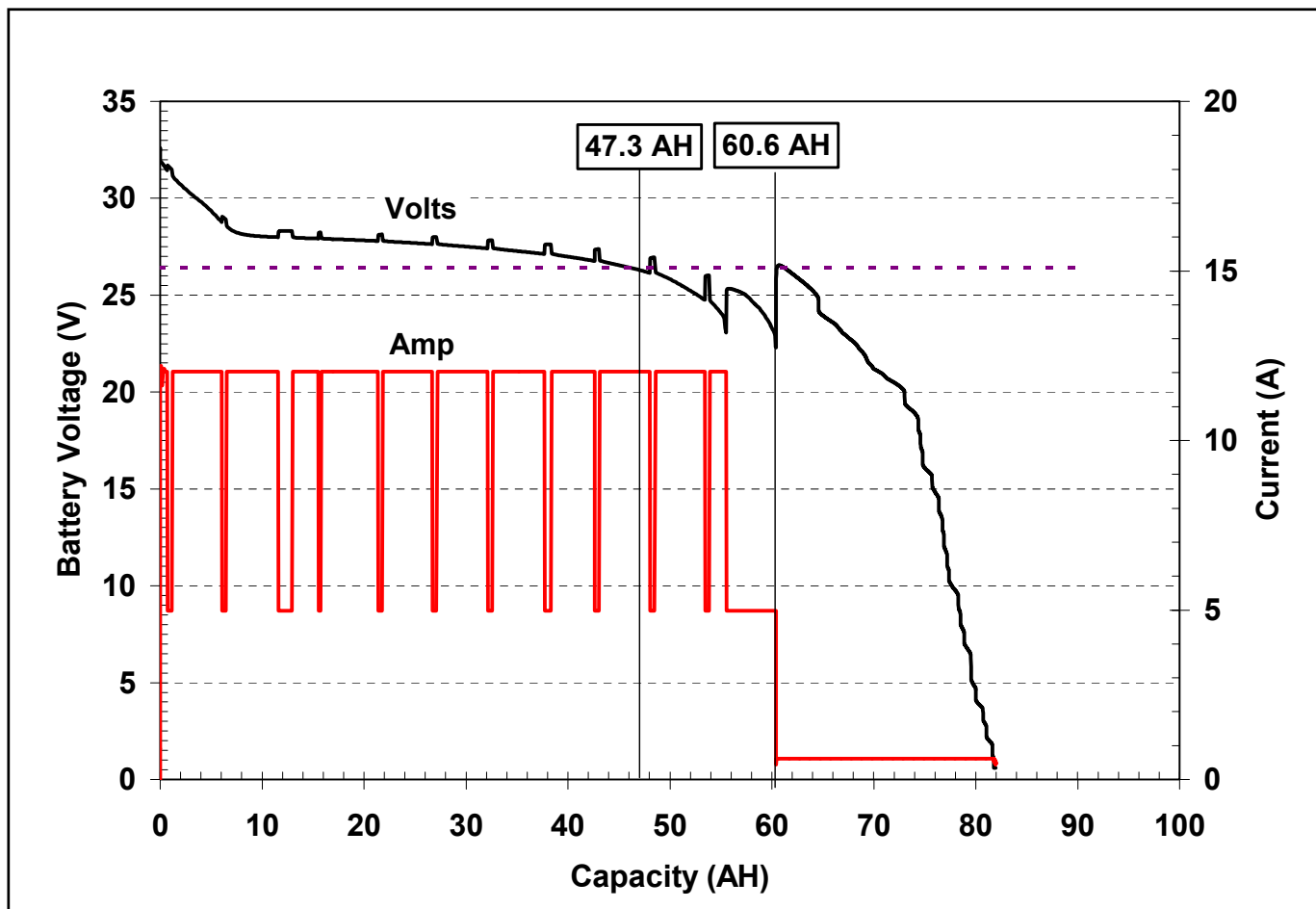


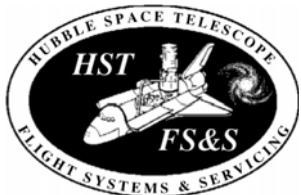
Battery Model Impedance Prediction



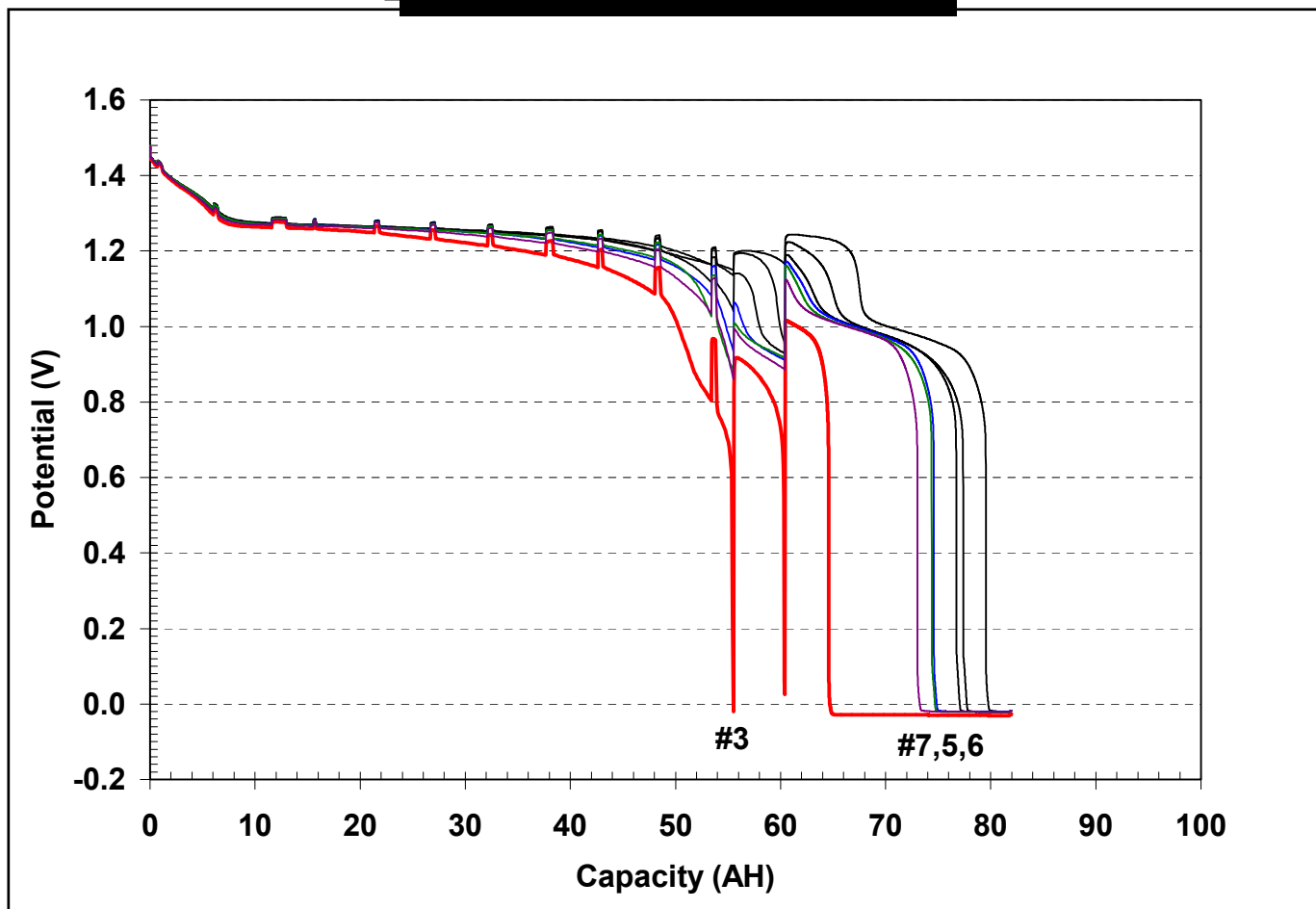


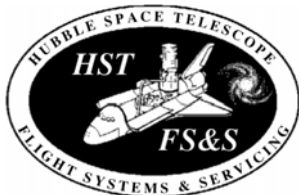
Flight Spare Battery Pulse Discharge



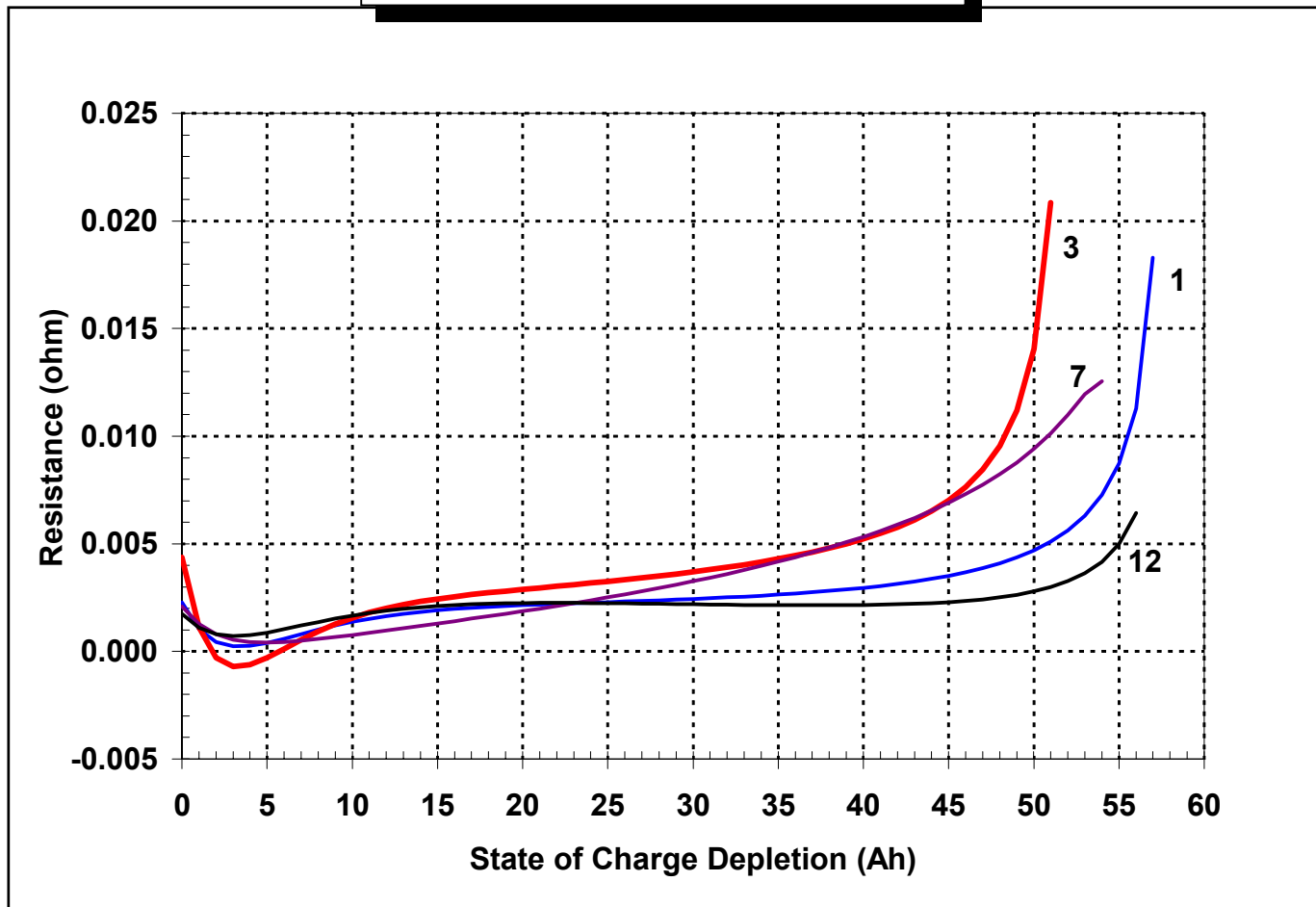


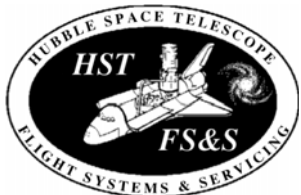
Flight Spare Battery Cell Potential Distribution



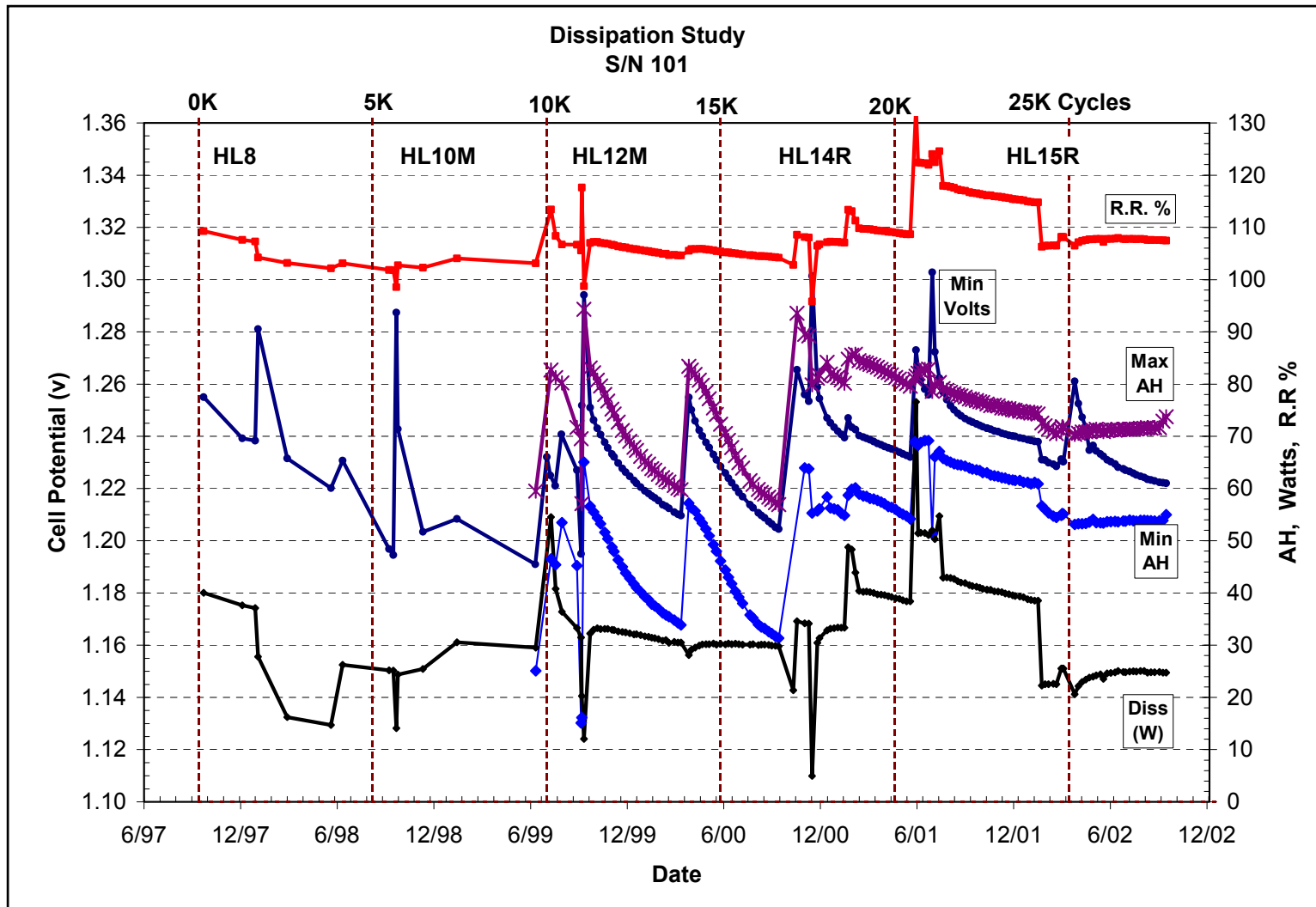


Flight Spare Battery Cell Impedance Distribution

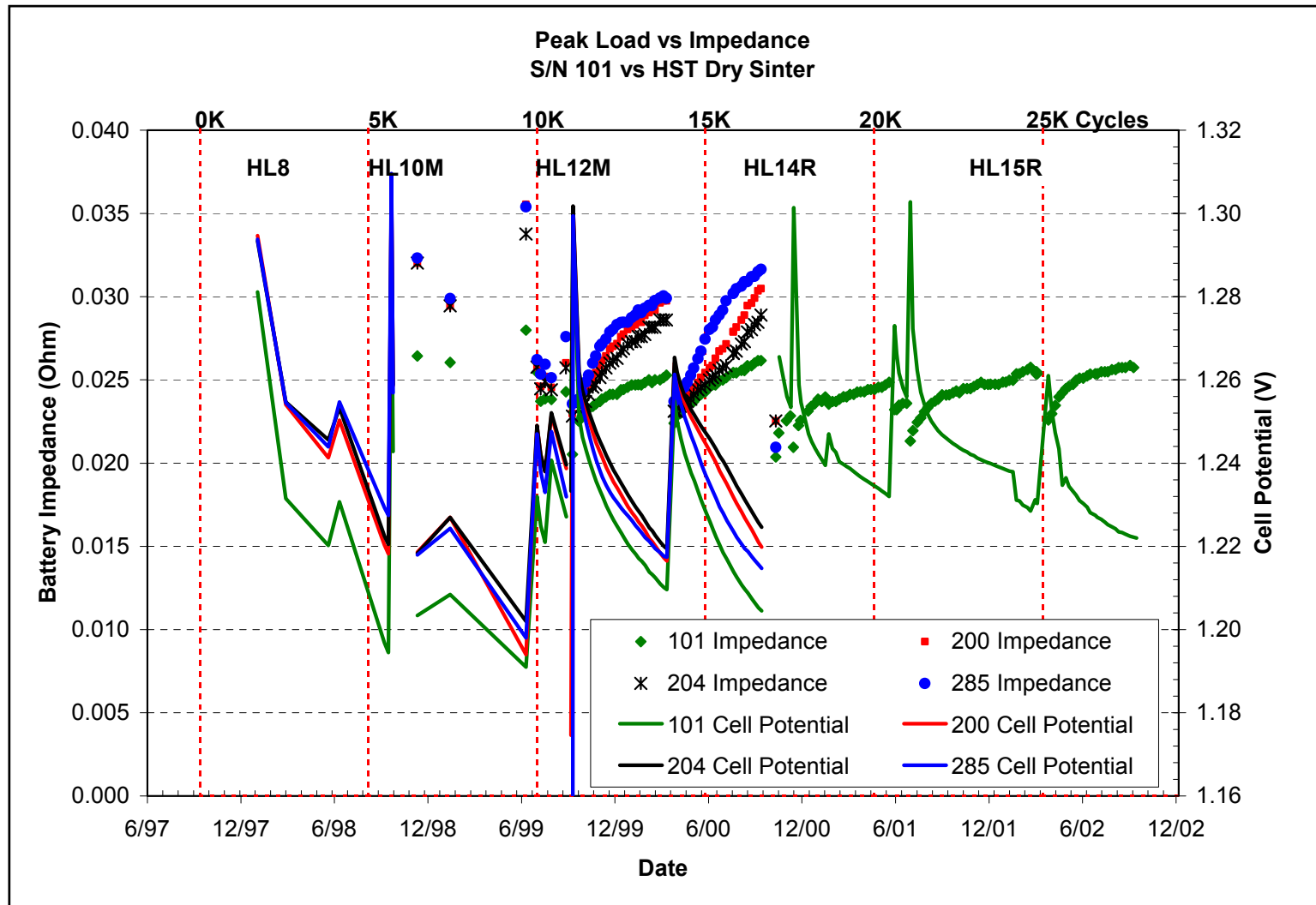


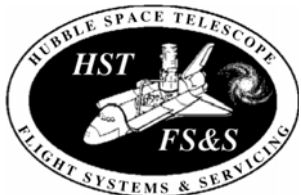


Cell Life Study 9/1/97 - 11/1/02

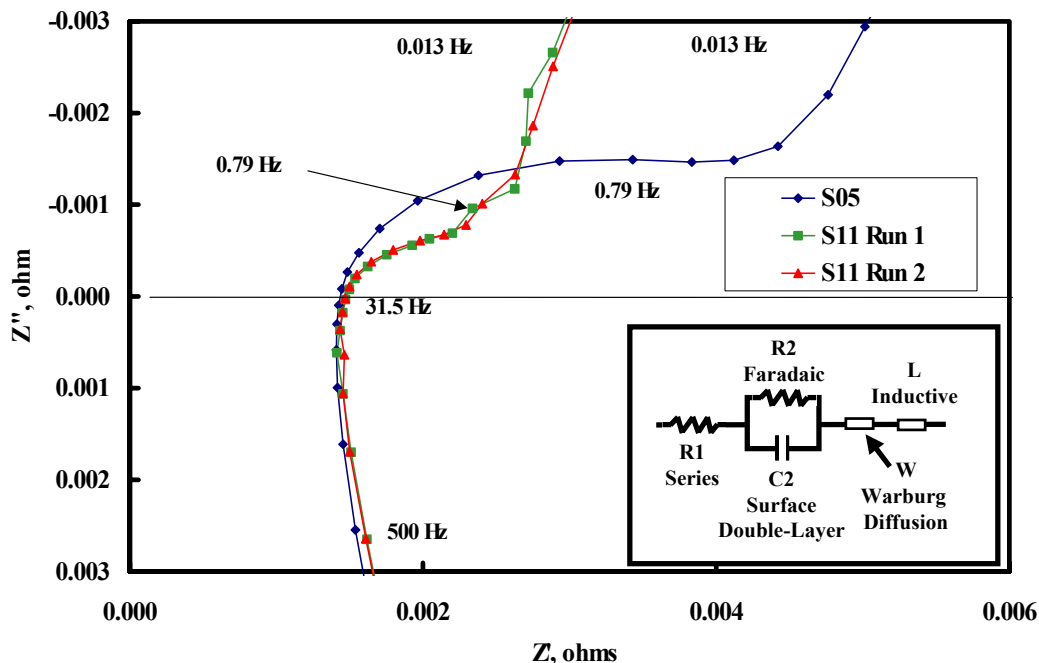


Cell Life Study 9/1/97 - 11/1/02

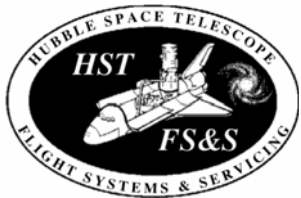




AC Impedance - GEO Ground Cycling (RNH 76-11 Dry Sinter)

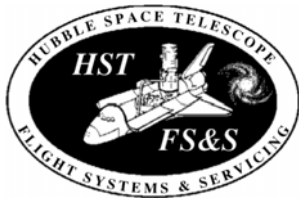


	S/N 11	S/N 05	Interpretation of Results <ul style="list-style-type: none"> • Decrease in Active Surface (R2, C2) • Electrode Surface Effect (R2, C2) • No Difference at High-Frequency (R1 - No Separator Difference) • Inductive Effects Ignored
Seasons	15 (Real)	58 (Accel.)	
R1, milliohms	1.4	1.4	
R2, milliohms	0.8	2.4	
C2, farads	44	26	



REFERENCES

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 - For the Hubble Space Telescope Low Earth Orbit Mission
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- **LMMSO Wishes to Acknowledge the Technical Support From**
 - HST Program Office for Orbital Data
 - NASA/MSFC for Ground Test Data.